## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10605944	BOUDON ET AL.
Examiner	Art Unit
Wai, Eric C	2195

SEARCHED						
Class	Subclass	Date	Examiner			
718	100	07/09/2007	ECW			
365	221	12/14/2007	ECW			
711	144	6/4/2008	ECW			
370	545	6/4/2008	ECW			

SEARCH NOTES				
Search Notes	Date	Examiner		
Inventor's Name Search	07/09/2007	ECW		
East Search	07/09/2007	ECW		
Updated East Search	12/14/2007	ECW		
Google Scholar Search	12/14/2007	ECW		
Updated East Search	6/4/2008	ECW		

INTERFERENCE SEARCH						
Class	Subclass	Date	Examiner			

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